

Data Sheet May 2001 File Number 5031

## 4A, 600V Stealth™ Diode

The ISL9R460P2 is a Stealth<sup>TM</sup> diode optimized for low loss performance in high frequency hard switched applications. The Stealth<sup>TM</sup> family exhibits low reverse recovery current ( $I_{RRM}$ ) and exceptionally soft recovery under typical operating conditions.

This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low  $I_{RRM}$  and short  $t_a$  phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the Stealth  $^{TM}$  diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost.

Formerly developmental type TA49408.

### **Ordering Information**

PART NUMBER	PACKAGE	BRAND
ISL9R460P2	TO-220AC	R460P2

NOTE: When ordering, use the entire part number.

# Symbol



#### Features

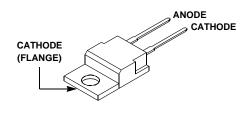
•	Soft Recovery $t_b / t_a > 3$
•	Fast Recovery $t_{rr}$ < 20ns
•	Operating Temperature
•	Reverse Voltage
•	Avalanche Energy Rated

## **Applications**

- Switch Mode Power Supplies
- · Hard Switched PFC Boost Diode
- UPS Free Wheeling Diode
- Motor Drive FWD
- SMPS FWD
- Snubber Diode

### Packaging

**JEDEC TO-220AC** 



### **Absolute Maximum Ratings** T<sub>C</sub> = 25°C, Unless Otherwise Specified

SYMBOL PARAMETER		ISL9R460P2	UNITS	
$V_{RRM}$	V <sub>RRM</sub> Peak Repetitive Reverse Voltage		V	
V <sub>RWM</sub> Working Peak Reverse Voltage		600	V	
V <sub>R</sub> DC Blocking Voltage		600	V	
I <sub>F(AV)</sub>	Average Rectified Forward Current	4	Α	
I <sub>FRM</sub>	Repetitive Peak Surge Current (20kHz Square Wave)	8	Α	
I <sub>FSM</sub>	Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60Hz)	50	Α	
P <sub>D</sub>	Power Dissipation	58	W	
E <sub>AVL</sub> Avalanche Energy (1A, 20mH)		10	mJ	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to 175	°С	
T <sub>L</sub> T <sub>pkg</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s Package Body for 10s, See Techbrief TB334	300 260	°C	
ERMAL SPECIFIC	CATIONS	<u> </u>	1	
$R_{ heta JC}$	Thermal Resistance Junction to Case	2.6	oC/W	
R <sub>0JA</sub> Thermal Resistance Junction to Ambient		62	°C/W	

NOTES:

**CAUTION:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## ISL9R460P2

**Electrical Specifications**  $T_C = 25^{\circ}C$ , Unless Otherwise Specified

SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
V <sub>F</sub>	I <sub>F</sub> = 4A	-	2.0	2.4	V
	I <sub>F</sub> = 4A, T <sub>C</sub> = 125°C	-	1.6	2.0	V
I <sub>R</sub>	V <sub>R</sub> = 600V	-	-	100	μΑ
	$V_R = 600V, T_C = 125^{\circ}C$	-	-	1.0	mA
t <sub>rr</sub>	$I_F = 1A$ , $dI_F/dt = 100A/\mu s$ , $V_R = 30V$	-	17	20	ns
	$I_F = 4A$ , $dI_F/dt = 100A/\mu s$ , $V_R = 30V$	-	19	22	ns
t <sub>rr</sub>	$I_F = 4A$ , $dI_F/dt = 200A/\mu s$ , $V_R = 390V$ , $T_C = 25^{\circ}C$	-	17	-	ns
I <sub>RRM</sub>		-	2.6	-	А
Q <sub>RR</sub>		-	22	-	nC
t <sub>rr</sub>	$I_F = 4A$ , $dI_F/dt = 200A/\mu s$ , $V_R = 390V$ , $T_C = 125^{\circ}C$	-	77	-	ns
S		-	4.2	-	
I <sub>RRM</sub>		-	2.8	-	А
Q <sub>RR</sub>		-	100	-	nC
t <sub>rr</sub>	$I_F = 4A$ , $dI_F/dt = 400A/\mu s$ , $V_R = 390V$ , $T_C = 125^{o}C$	-	54	-	ns
S		-	3.5	-	
I <sub>RRM</sub>		-	4.3	-	А
Q <sub>RR</sub>		-	110	-	nC
dI <sub>M</sub> /dt		-	500	-	A/μs
СЛ	V <sub>R</sub> = 10V, I <sub>F</sub> = 0A	-	19	-	pF

## **DEFINITIONS**

 $V_F$  = Instantaneous forward voltage (pw = 300 $\mu$ s, D = 2%)

pw = pulse width.

D = Duty cycle

 $I_R$  = Instantaneous reverse current.

 $t_{rr}$  = Reverse recovery time  $(t_a + t_b)$ .

S = Softness factor  $(t_b / t_a)$ .

 $I_{RRM}$  = Maximum reverse recovery current.

Q<sub>RR</sub> = Reverse recovery charge.

 $dI_{M}/dt = Maximum di/dt during t_{b}$ .

C<sub>J</sub> = Junction Capacitance.

## **Typical Performance Curves**

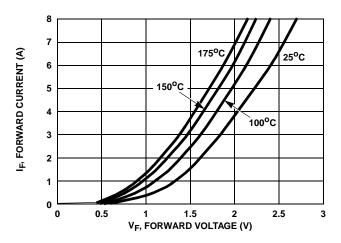


FIGURE 1. FORWARD CURRENT vs FORWARD VOLTAGE

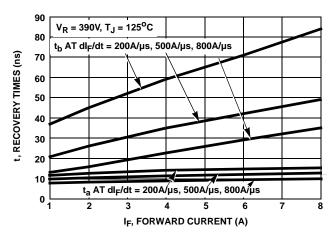


FIGURE 3.  $t_a$  AND  $t_b$  CURVES vs FORWARD CURRENT

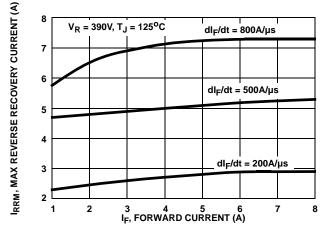


FIGURE 5. MAXIMUM REVERSE RECOVERY CURRENT vs FORWARD CURRENT

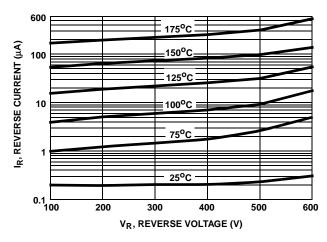


FIGURE 2. REVERSE CURRENT vs REVERSE VOLTAGE

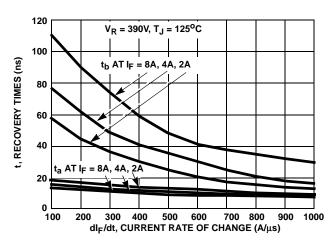


FIGURE 4. ta AND tb CURVES vs dlF/dt

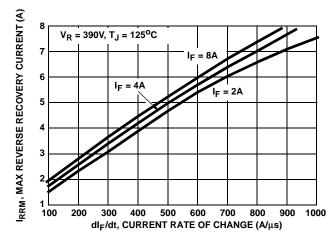
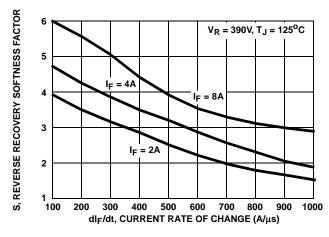


FIGURE 6. MAXIMUM REVERSE RECOVERY CURRENT vs  $dI_F/dt$ 

## Typical Performance Curves (Continued)



180 Q<sub>RR</sub>, REVERSE RECOVERY CHARGE (nC)  $V_R = 390V, T_J = 125^{\circ}C$ I<sub>F</sub> = 8A 160 140  $I_F = 4A$ 120 100  $I_F = 2A$ 80 100 300 400 500 600 700 800 dI<sub>F</sub>/dt, CURRENT RATE OF CHANGE (A/μs)

FIGURE 7. REVERSE RECOVERY SOFTNESS FACTOR vs dIF/dt

FIGURE 8. REVERSE RECOVERY CHARGE vs dl<sub>F</sub>/dt

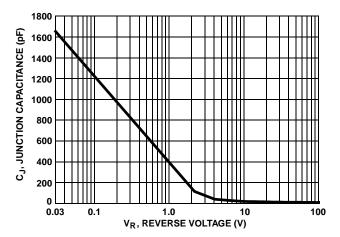


FIGURE 9. JUNCTION CAPACITANCE vs REVERSE VOLTAGE

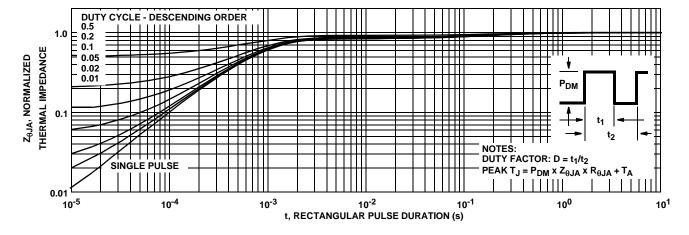


FIGURE 10. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

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### **Test Circuits and Waveforms**

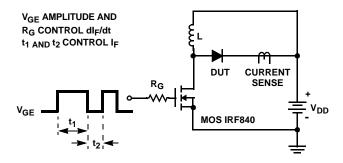


FIGURE 11.  $t_{rr}$  TEST CIRCUIT

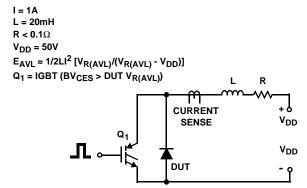


FIGURE 13. AVALANCHE ENERGY TEST CIRCUIT

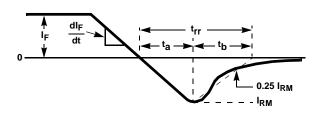


FIGURE 12.  $t_{rr}$  WAVEFORMS AND DEFINITIONS

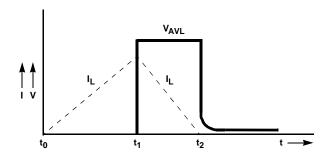
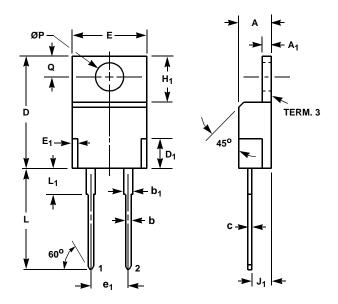


FIGURE 14. AVALANCHE CURRENT AND VOLTAGE WAVEFORMS

## **TO-220AC**

# 2 LEAD JEDEC TO-220AC PLASTIC PACKAGE (FOR RECTIFIERS ONLY)



	INCHES		MILLIMETERS		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	0.170	0.180	4.32	4.57	-
A <sub>1</sub>	0.048	0.052	1.22	1.32	-
b	0.030	0.034	0.77	0.86	3, 4
b <sub>1</sub>	0.045	0.055	1.15	1.39	2, 3
С	0.014	0.019	0.36	0.48	2, 3, 4
D	0.590	0.610	14.99	15.49	-
D <sub>1</sub>	-	0.160	-	4.06	-
Е	0.395	0.410	10.04	10.41	-
E <sub>1</sub>	-	0.030	-	0.76	-
e <sub>1</sub>	0.200 BSC		5.08 BSC		5
H <sub>1</sub>	0.235	0.255	5.97	6.47	-
J <sub>1</sub>	0.100	0.110	2.54	2.79	6
L	0.530	0.550	13.47	13.97	-
L <sub>1</sub>	0.130	0.150	3.31	3.81	2
ØP	0.149	0.153	3.79	3.88	-
Q	0.102	0.112	2.60	2.84	-

#### NOTES:

- These dimensions are within allowable dimensions of Rev. J of JEDEC TO-220AC outline dated 3-24-87.
- 2. Lead dimension and finish uncontrolled in L<sub>1</sub>.
- 3. Lead dimension (without solder).
- 4. Add typically 0.002 inches (0.05mm) for solder coating.
- 5. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
- 6. Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
- 7. Controlling dimension: Inch.
- 8. Revision 3 dated 7-97.

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Stealth™

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